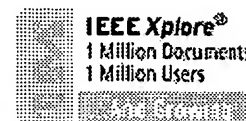


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Example: optical &lt;and&gt; (fiber &lt;or&gt; fibre) &lt;in&gt; ti

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perpendicular <and>  
 ((magnetic disk) <or>  
 (magnetic disc) <or>  
 (magnetic medium) <or>  
 (magnetic media)) <and> (multilevel <or>  
 multilayer <or> (multiple  
 levels) <or> (multiple  
 magnetic levels) <or> (multiple layers) <or>  
 (multiple magnetic layers))

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